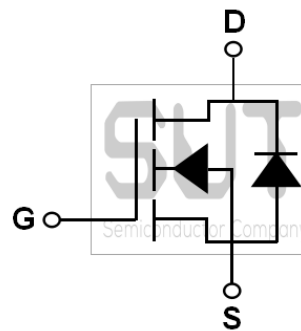
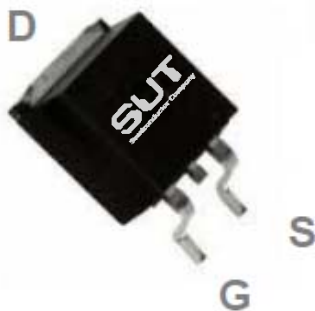


N-Channel 100-V_(D-S) SGT MOSFET

| PRODUCT SUMMARY | | |
|-----------------------|-------------------------------|--------------------|
| B _{VDSS} (V) | R _{DS(on)} (mΩ)(MAX) | I _D (A) |
| 100 | 4.2@V _{GS} =10V | 150 |

TO263 Pin Configuration



ABSOLUTE MAXIMUM RATINGS(T_C=25°C UNLESS OTHERWISE NOTED)

| Parameter | Symbol | Rating | Units |
|--|------------------|------------|-------|
| Drain-Source Voltage | V _{DS} | 100 | V |
| Gate-Source Voltage | V _{GS} | +20/-12 | V |
| Drain Current-Continuous (T _C =25°C) | I _D | 150 | A |
| Drain Current-Continuous (T _C =100°C) | | 95 | A |
| Drain Current-Pulsed ¹ | I _{DM} | 600 | A |
| Single Pulse Avalanche Energy ² | EAS | 378 | mJ |
| Single Pulse Avalanche Current ² | IAS | 87 | A |
| Power Dissipation (T _C =25°C) | P _D | 275 | W |
| Power Dissipation-Derate above 25°C | | 2.22 | W/°C |
| Storage Temperature Range | T _{STG} | -50 to 150 | °C |
| Operating Junction Temperature Range | T _J | -50 to 150 | °C |

THERMAL CHARACTERISTICS

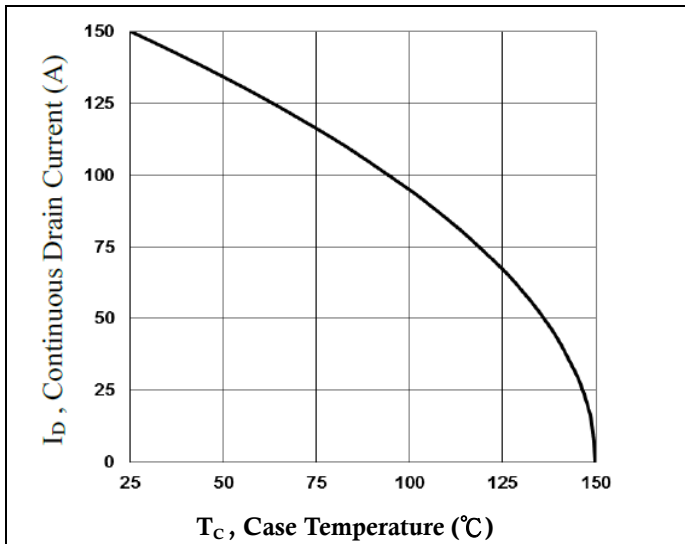
| Parameter | Symbol | Typ. | Max. | Unit |
|--|------------------|------|------|------|
| Thermal Resistance Junction to ambient | R _{θJA} | --- | 62 | °C/W |
| Thermal Resistance Junction to Case | R _{θJC} | --- | 0.45 | °C/W |

| ELECTRICAL CHARACTERISTICS (T _J =25°C UNLESS OTHERWISE NOTED) | | | | | | |
|--|---------------------|---|------|------|-------|------|
| Parameter | Symbol | Test Condition | Min. | Typ. | Max. | Unit |
| Off Characteristics | | | | | | |
| Drain-Source Breakdown Voltage | BV _{DSS} | V _{GS} =0V, I _D =250uA | 100 | --- | --- | V |
| Drain-Source Leakage Current | I _{DSS} | V _{GS} =0V, V _{DS} =100V, T _J =25°C | --- | --- | 1 | uA |
| | | V _{GS} =0V, V _{DS} =80V, T _J =85°C | --- | --- | 10 | uA |
| Gate-Source Leakage Current | I _{GSS} | V _{GS} =20V, V _{DS} =0V | --- | --- | 100 | nA |
| On Characteristics | | | | | | |
| Static Drain-Source On-Resistance | R _{DS(ON)} | V _{GS} =10V, I _D =20A | --- | 3.5 | 4.2 | mΩ |
| Gate Threshold Voltage | V _{GS(th)} | V _{GS} =V _{DS} , I _D =250uA | 2.0 | --- | 4.0 | V |
| Forward Transconductance | g _{fs} | V _{DS} =10V, I _D =3A | --- | 20 | --- | S |
| Dynamic and Switching Characteristics | | | | | | |
| Total Gate Charge ^{3, 4} | Q _g | V _{GS} =10V, V _{DS} =80V, I _D =10A | --- | 110 | 165 | nC |
| Gate-Source Charge ^{3, 4} | Q _{gs} | | --- | 11.5 | 18 | |
| Gate-Drain Charge ^{3, 4} | Q _{gd} | | --- | 28 | 42 | |
| Turn-On Delay Time ^{3, 4} | T _{d(on)} | V _{GS} =10V, V _{DD} =50V, R _G =6Ω, I _D =1A | --- | 23 | 46 | ns |
| Rise Time ^{3, 4} | T _r | | --- | 32 | 64 | |
| Turn-Off Delay Time ^{3, 4} | T _{d(off)} | | --- | 157 | 320 | |
| Fall Time ^{3, 4} | T _f | | --- | 115 | 230 | |
| Input Capacitance | C _{iss} | V _{GS} =0V, V _{DS} =25V, F=1MHz | --- | 6680 | 13300 | pF |
| Output Capacitance | C _{oss} | | --- | 1690 | 3380 | |
| Reverse Transfer Capacitance | C _{rss} | | --- | 78 | 156 | |
| Gate resistance | R _g | V _{GS} =0V, V _{DS} =0V, F=1MHz | --- | 1.9 | --- | Ω |
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| Continuous Source Current | I _S | V _G =V _D =0V, Force Current | --- | --- | 150 | A |
| Pulsed Source Current | I _{SM} | | --- | --- | 300 | A |
| Diode Forward Voltage | V _{SD} | V _{GS} =0V, I _S =1A, T _J =25°C | --- | --- | 1.0 | V |

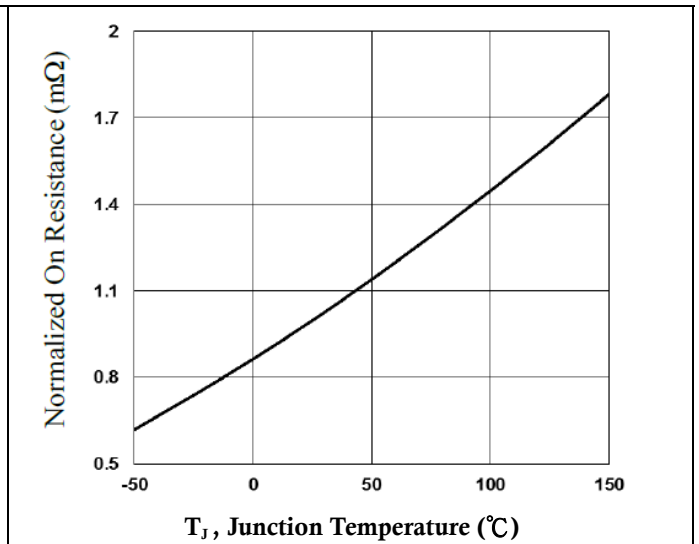
Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. V_{GS}=10V, V_{DD}=25V, L=0.1mH, I_{AS}=87A, R_G=25Ω, Starting T_J=25°C.
3. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
4. Essentially independent of operating temperature.

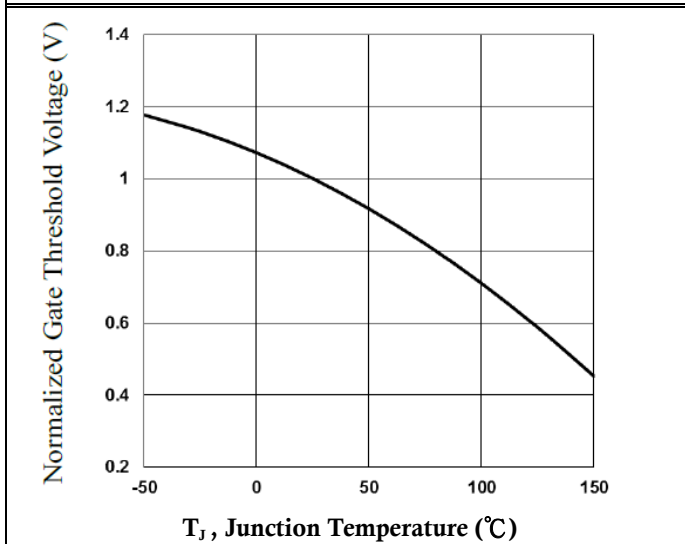
100V N-Channel MOSFETs



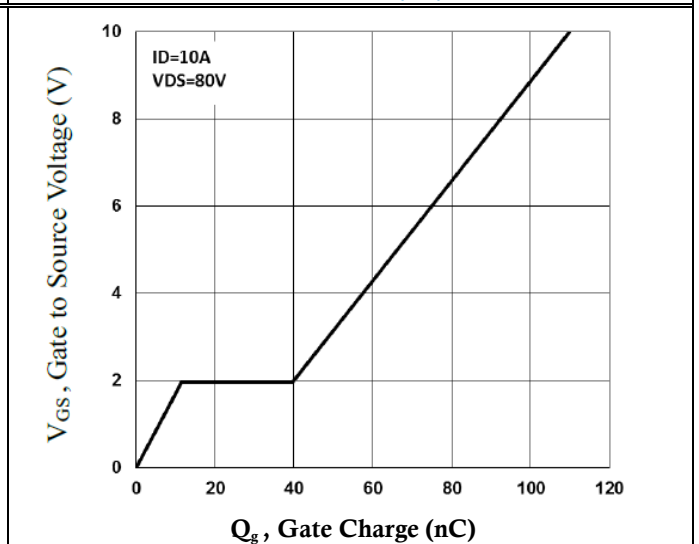
Continuous Drain Current vs. T_C



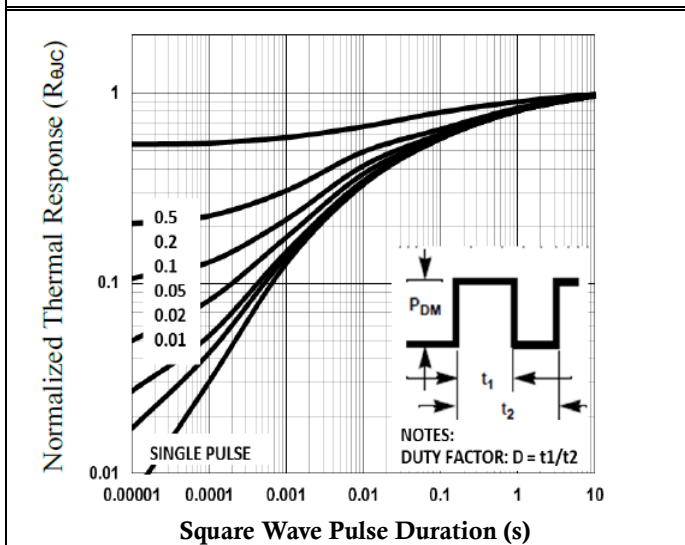
Normalized $R_{DS(ON)}$ vs. T_J



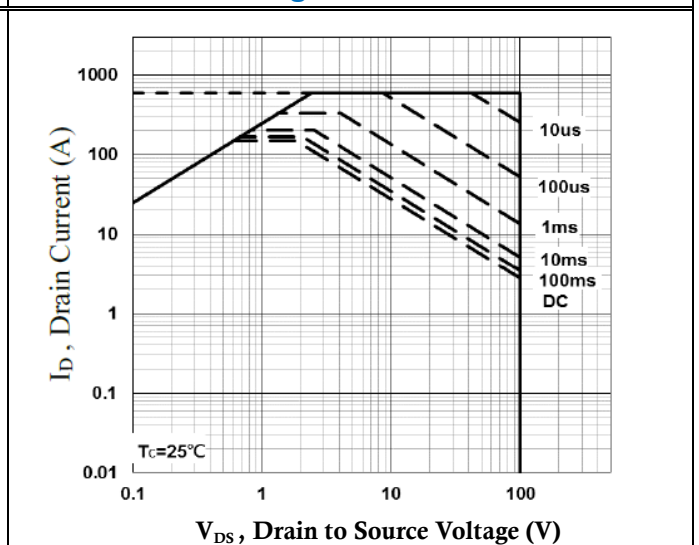
Normalized V_{th} vs. T_J



Gate Charge Characteristics



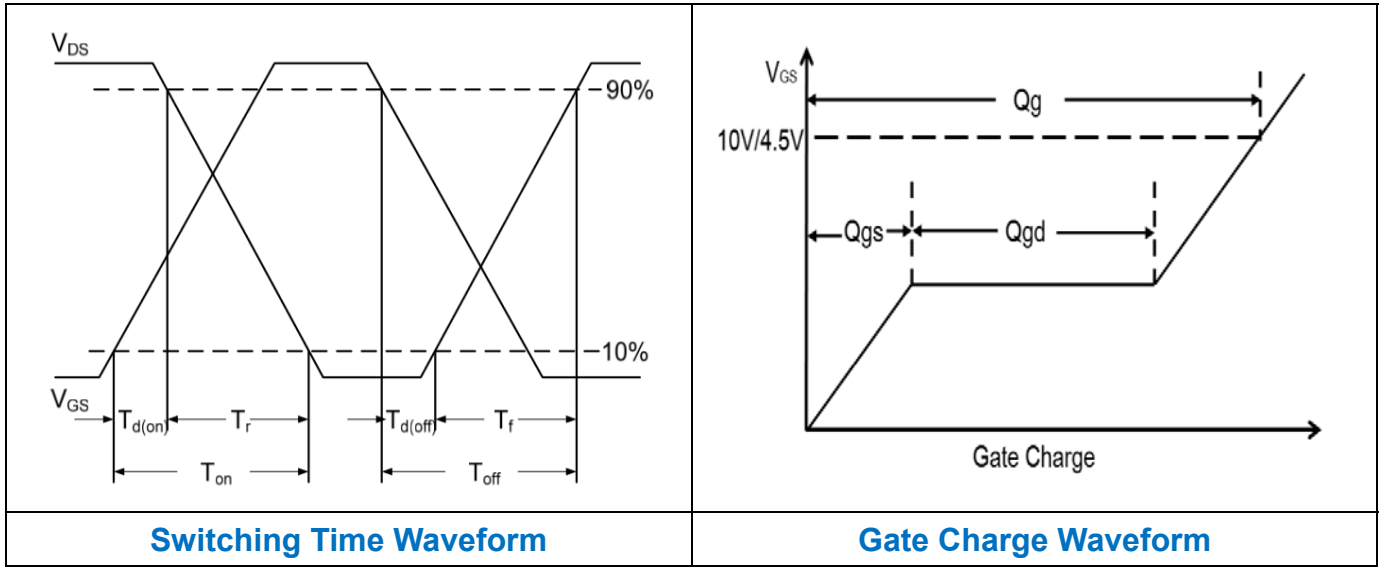
Normalized Transient Impedance



Maximum Safe Operation Area

SUT9080Z

100V N-Channel MOSFETs



TO263 PACKAGE INFORMATION

